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Application/Control No.

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Applicant(s)/Patent Under

Reexamination

SPECHT ET AL.

Examiner

James Martinell

Art Unit

1631

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	WO-98/07749	02-1998	WO	Yu et al	---
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NON-PATENT DOCUMENTS

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